

10/516414 #3
DT09 R PCT/PTO 02 DEC 2004

Docket No.: SON-2774
(PATENT)

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Patent Application of:
Kaoru Koike

Application No.: Not Yet Assigned

Confirmation No.:

Filed: December 2, 2004

Art Unit: N/A

For: MASK, METHOD OF PRODUCING THE
SAME, AND METHOD OF PRODUCING
SEMICONDUCTOR DEVICE

Examiner: Not Yet Assigned

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Dear Sir:

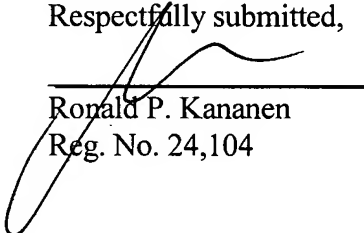
In accordance with the requirements of 37 CFR §§ 1.56 and MPEP 609, applicant through his attorneys and representatives, hereby brings to the attention of the Examiner the references noted on the attached Form PTO-1449, copies of which are enclosed.

The references are cited in the International Search Report of applicant's corresponding PCT Application No. PCT/JP03/07377 a copy of which is enclosed.

It is requested that the Examiner review the references noted and make such consideration of record.

Respectfully submitted,

Dated: December 2, 2004



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Substitute for form 1449A/B/PTO INFORMATION DISCLOSURE STATEMENT BY APPLICANT <i>(Use as many sheets as necessary)</i>				Complete If Known	
				Application Number	Not Yet Assigned
				Filing Date	December 2, 2004
				First Named Inventor	Kaoru Koike
				Art Unit	N/A
				Examiner Name	Not Yet Assigned
Sheet	1	of	1	Attorney Docket Number	SON-2774

U.S. PATENT DOCUMENTS					
Examiner Initials*	Cite No. ¹	Document Number	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		Number-Kind Code ² (if known)			
	AA	5,728,492	03-17-1998	Kawata	
	AB	2002/0058400 A1	05-16-2002	Suguro et al.	
	AC	4,448,865	05-15-1984	Bohlen et al.	
	AD	6,319,636 B1	11-20-2001	Ham	

FOREIGN PATENT DOCUMENTS						
Examiner Initials*	Cite No. ¹	Foreign Patent Document	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	T ⁶
		Country Code ³ -Number ⁴ -Kind Code ⁵ (if known)				
	BA	JP 04-243118	08-31-1992	Fujitsu Ltd.		<input checked="" type="checkbox"/>
	BB	JP 09-034103	02-07-1997	Nikon Corp.		<input checked="" type="checkbox"/>
	BC	JP 58-106822 A	06-25-1983	Hitachi Ltd.		
	BD	JP 2002-203806	07-19-2002	Toshiba Corp.		
	BE	JP 58-190029	11-05-1983	International Business Machines Corp.		
	BF	JP 2000-195790	07-14-2000	Hyundai Electronics Ind. Co.		
	BG	JP 10-207045 A	08-07-1998	Nikon Corp.		
	BH					
	BI					
	BJ					
	BK					
	BL					

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant. ¹ Applicant's unique citation designation number (optional). ² See Kinds Codes of USPTO Patent Documents at www.uspto.gov or MPEP 901.04. ³ Enter Office that issued the document, by the two-letter code (WIPO Standard ST.3). ⁴ For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document. ⁵ Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST.16 if possible. ⁶ Applicant is to place a check mark here if English language Translation is attached.

NON PATENT LITERATURE DOCUMENTS			
Examiner Initials*	Cite No. ¹	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T ²
	CA	International Search Report dated September 9, 2003	

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¹ Applicant's unique citation designation number (optional). ² Applicant is to place a check mark here if English language Translation is attached.

Examiner Signature		Date Considered	
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